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A DFT-Based Cu(111)||Cu₂O(111) Model for Copper Metal Covered by Ultrathin Copper Oxide: Structure, Electronic Properties and Reactivity

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Abstract

In many applications, metallic copper can be covered by an ultrathin native or a passive oxide film depending on the redox conditions of the interface formed with the environment, which governs its surface properties. In the present work, we constructed and optimized through quantum chemical DFT calculations a model of this Cu(111)||Cu₂O(111) stoichiometric oxide supported in parallel epitaxy on Cu(111) substrate. Energetic analysis of the metal-oxide interface shows the stable formation of the interface between oxide film and metal substrate. The Cu₂O(111) film binds to the Cu(111) surface via the unsaturated oxygen atoms bonded to copper metal atoms in top, bridge and hollow sites. Structural analysis of the Cu₂O(111) film surface shows reconstruction with modifications of the distances between the unsaturated and the saturated copper atoms. The surface interlayer relaxation is inward for

Cu(111)||Cu₂O(111), whereas it is outward for the non supported Cu₂O(111) oxide, and converges to that of bulk oxide with increasing the Cu₂O(111) thickness. The electronic work function is not significantly modified with respect to the Cu(111) electronic work function, whatever the oxide thickness. The hydration of the surface is energetically favorable and water molecular adsorption is favored over dissociative adsorption. Water molecules chemisorb on top over unsaturated copper atoms. The hydroxylation of the surface shows two adsorption modes of the OH groups on top over unsaturated Cu atoms and on bridge site between unsaturated and saturated Cu atoms.

Introduction

The formation, chemical composition and structure of a surface oxide film is crucial in important technological processes based on surface properties, such as corrosion protection,¹ energy conversion² and catalysis.^{3,4} The presence, composition and structure of an oxide overlayer on metallic substrate is determined by the redox conditions of the interface formed with the environment. On copper in aqueous environmental conditions, the formation of a protective anodic oxide depends on the nature of the electrolyte, pH, potential of solid-liquid interface, immersion and polarization time.

For some decades theoretical works have been performed to better understand the structure of metal surfaces and their electronic properties and reactivity for a variety of application domains,⁵⁻⁷ ranging from heterogeneous catalysis to corrosion protection. One of the prerequisite conditions for a relevant theoretical approach is that the modeled system is representative of the experimental conditions. For surfaces, the chemical and structural state of the surface layers plays a key role in the reactivity and it is mandatory to model properly the surface terminations.

In the case of copper, the surface has been shown to be in the metallic state in acidic solutions (pH < 5),^{8,9} due to the fast dissolution of the oxide, and also in alkaline solutions in the underpotential range of Cu₂O formation. This has been observed in 1 mM K₂SO₄

alkaline solution of pH 8 or 10 at potential $E < -0.90$ V,¹⁰ in 0.1 M NaOH solution of pH 13 at -0.675 ± 0.02 V/SHE¹¹ and at potential $E < -0.75$ V.¹² Under these conditions, a theoretical model composed of a Cu(hkl) metal slab is appropriate to investigate adsorbate-copper interactions at the atomic scale.^{12,13}

In contrast, at pH > 5 and in the overpotential range of copper oxide formation, copper is covered by an anodic oxide film of Cu₂O or Cu₂O/CuO depending on potential. This oxide film is generally ultrathin, ranging from 1 to 4 nm depending on the experimental conditions. The oxide thickness has been estimated experimentally to be < 4 nm in 0.1 M KOH alkaline solution,¹⁴ 2.2 ± 0.3 nm in 3 wt.% NaCl neutral solution¹⁵ and to not exceed 1.4 nm in 0.1 M phosphate buffer solution of pH 7 and 8 and in borax buffer solution of pH 9.2.¹⁶ In 0.1 M NaOH solution of pH 13, at potential $E = 0.75$,^{1,17} a duplex film is formed on Cu(111), with an inner layer of Cu₂O(111) oxide 1-1.6 nm thick and a mixed outer layer of CuO/CuOH about 2-4 nm thick. At potential ≤ -0.25 V, the thickness of Cu₂O is below 7 monolayers.^{1,5}

In order to describe the available experimental data at the atomic scale with theoretical models of the oxidized surface, several groups used non supported Cu₂O(111) oxide surfaces,¹⁸⁻²⁰ obtained by cleavage of the bulk Cu₂O oxide structure. This approach is adequate when the oxide on top of the metal is thick enough to have the electronic properties of the bulk oxide. Therefore, one can neglect the underling metal part and only investigate the adsorbate-oxide surface interactions.

This theoretical modeling approach may not be appropriate to study the adsorbate-substrate interactions when copper is covered by an ultrathin oxide layer. Most of the theoretical models of oxidized copper found in the literature which are related to the formation of the oxide on the copper metal are focused on the adsorption of oxygen on the Cu(111) surface. Using a model consisting of a Cu(111) slab covered by a single CuOx oxide layer,²¹ Gharachorlou et al. have shown that TMA (trimethylaluminum) adsorption occurs on oxidized Cu but not on metallic Cu. Using DFT, An et al.²² have shown that

the deposition of potassium impacts the surface electronic structure with a $\text{Cu}_x\text{O}/\text{Cu}(111)$ ($x \leq 2$) model and the results agreed with STM measurements. The structural model for the “29”-structure of $\text{Cu}_x\text{O}/\text{Cu}(111)$ was studied by DFT and STM techniques over a range of scanning biases.^{23,24} The “29” oxide acts as a precursor to bulk oxidation and the phase diagram shows that when the O chemical potential is high enough, bulk $\text{Cu}_2\text{O}(111)$ oxide formation takes place and it is the preferred species.²³ Park et al. studied the adsorption of molecular fragments of pyromellitic dianhydride oxydianiline (PMDA-ODA) on pristine and mildly oxidized $\text{Cu}(111)$ surfaces.²⁵ A model based on the mismatch-overlayer structure of the (111) faces of Cu_2O and the Cu was proposed by Jensen et al.²⁶ Yang et al.²⁷ used the structural model of the $\text{Cu}_2\text{O}(111)$ -like monolayer on $\text{Cu}(111)$, with two types of oxygen species, chemisorbed oxygen and lattice oxygen within Cu_2O . Soon et al.²⁸ studied the chemisorption of oxygen and the thermodynamic stability of the surface oxide on $\text{Cu}(111)$. Their phase diagram (P,T), shows that the oxygen proceeds directly to the formation of a surface oxide structure and to the bulk oxide phase, which is in the line with experimental observation.

The growth and surface properties of cuprous oxide films depend on the support used.^{29–32} The underlying metal layers can impose a strain to the oxide surface that can affect the surface reactivity of the ultrathin copper oxide film. The oxide thickness can affect the reactivity.³³ In the presence of an adsorbate, the growth of the oxide layer can be limited. An XPS surface analysis revealed that the chemical surface state of the copper surface is very different in the absence or presence of a self-assembled monolayer of 4-fluorobenzenethiol (4-F-BT) pre-adsorbed on copper.³⁴ Without pre-adsorption the surface is typical of CuO and $\text{Cu}(\text{OH})_2$, whereas after 4-F-BT pre-adsorption, it shows the absence of Cu^{2+} and suggests the possible presence of Cu_2O traces as inferred from the analysis of the Cu Auger spectra at 570.4 eV. Recently, the pre-adsorption of 2-mercaptobenzothiazole (MBT) and 2-mercaptobenzimidazole (MBI) corrosion inhibitors at ultra low pressure on $\text{Cu}(111)$ has been shown to markedly retard the oxidation kinetics.^{35–37}

The choice of the metal/oxide interface model is of outermost importance, as many properties including corrosion resistance are related to the composition and electronic properties of this interface.²⁹ So, it is very important to elaborate the most realistic interfacial model. This is the reason why we have recently used a model of oxidized Cu consisting of Cu₂O(111) in parallel epitaxy on Cu(111), in order to study by Density Functional Theory (DFT) the adsorption of MBT, a known corrosion inhibitor, on the oxidized copper surface.³⁸

Here we detail the construction of this epitaxial Cu(111)||Cu₂O model. We discuss the construction of the model, the oxide/metal interface, the oxide surface relaxation and the electronic properties. The reactivity with water and OH groups is also studied and compared to results obtained on non supported Cu₂O(111) oxide surfaces from the literature.

Methods

DFT was used with the periodic plane-wave basis set code VASP (Vienna Ab initio Simulation Package).^{39–42} All results reported have been obtained with projector-augmented-wave potentials using a 450 eV plane-wave cut-off.^{43,44} The Generalized Gradient Approximation (GGA) of Perdew–Burke–Ernzerhof (PBE) functional was used for the exchange-correlation term.^{45,46} We used a Methfessel–Paxton smearing.⁴⁷ After preliminary calculations on the metal and oxide bulk structures, we opted for the Van der Waals contributions in the local van der Waals density functional scheme proposed by Dion et al⁴⁸ and Klimeš et al^{49–51} and calculations were carried out using OptB86b-vdw level.⁵⁰ The Brillouin-zone sampling was restricted to the Γ -point,⁵² due to the large supercell size used in the calculations. The supercell consists of four layers of copper metal oriented (111) covered by two to six stoichiometric Cu₂O(111) layers yielding a thickness varying from 5.89 to 16.24 Å. The vacuum region was set at more than 18 Å to minimize the interactions in the z direction between periodic images of the system. Optimizations were performed with restricted spin. The molecules (H₂O and OH° group) were adsorbed on top of the oxide layer. To calculate the energies of

the molecules in the gas phase, they were optimized in vacuum in a cell of $20\text{\AA} \times 20\text{\AA} \times 20\text{\AA}$ dimensions. The adsorbates, all layers of the oxide film and the two uppermost layers of the copper metal were allowed to move freely, and the two bottom layers of the metal were fixed. Atomic positions were relaxed with the conjugate gradient (CG) algorithm until forces on each moving atom were less than $0.02 \text{ eV}\text{\AA}^{-1}$.

Energetic

The cohesion energy of the $\text{Cu}_2\text{O}(111)$ oxide on the $\text{Cu}(111)$ metal was calculated as:

$$E_{\text{cohesion}} = (E(\text{metal}) + E(\text{oxide}) - E(\text{metal/oxide}))/A \quad (1)$$

where $E(\text{metal/oxide})$ is the total energy of the relaxed $\text{Cu}_2\text{O}(111)||\text{Cu}(111)$ system. $E(\text{oxide})$ and $E(\text{metal})$ are the total energies of the unrelaxed $\text{Cu}_2\text{O}(111)$ and $\text{Cu}(111)$ parts, respectively, as calculated after separation and A is the area of the slab.

The adsorption energy of the water molecule was calculated as:

$$E_{\text{ads}} = [E(\text{slab}/\text{H}_2\text{O}) - E(\text{slab}) - nE(\text{H}_2\text{O})]/n \quad (2)$$

where $E(\text{slab}/\text{H}_2\text{O})$ is the total energy of the system with the water adsorbed on the slab surface. $E(\text{slab})$ and $E(\text{H}_2\text{O})$ are the energies of the clean relaxed slab and of one free water molecule optimized in vacuum, respectively, and n is the number of the water molecules adsorbed on the surface.

The adsorption energy of the radical OH° was calculated as:

$$E_{\text{ads}} = [E(\text{slab}/\text{OH}^\circ) - E(\text{slab}) - nE(\text{OH}^\circ)]/n \quad (3)$$

where $E(\text{slab}/\text{OH})$ is the total energy of the system with the OH° groups adsorbed on the slab surface. $E(\text{OH}^\circ)$ is the energy of one free radical OH° optimized in vacuum and n is the number of OH adsorbed on the surface.

In order to compare the stabilities at low and full (i.e. saturation) coverage of the adsorption of H_2O and OH° , we normalized the adsorption energy per unit area as follows:

$$\varepsilon_{\text{norm}} = E_{\text{ads}} \times \theta \quad (4)$$

where E_{ads} is the adsorption energy per molecule and $\theta = \frac{n}{A}$ the coverage, defined as the number of adsorbed molecules (n) per area (A) of the slab.

Electronic and charge analysis

The charge density difference analysis was plotted as:

$$\Delta\rho(r) = \rho(r)_{\text{slab/mol}} - (\rho(r)_{\text{slab}} + \rho(r)_{\text{mol}}) \quad (5)$$

where $\rho(r)_{\text{slab/mol}}$ is the charge density distribution on the system, and $\rho(r)_{\text{slab}}$ and $\rho(r)_{\text{mol}}$ are the charge density distributions on the isolated substrate and molecule at the geometry after adsorption, respectively.

The net charge variation was determined on each atom as:

$$\Delta Q(x) = Q_{\text{ads}}(x) - Q_{\text{vac}}(x) \quad (6)$$

where the $Q_{\text{ads}}(x)$ and $Q_{\text{vac}}(x)$ are the net charge on each atom (Bader population analysis)⁵³ of the molecule and the slab before and after adsorption, respectively.

The work function change induced by the formation of the oxide on the metallic surface was calculated by:

$$\Delta\phi = \phi' - \phi \quad (7)$$

where ϕ' and ϕ are the work functions for the surface covered by the oxide and the bare metallic surface, respectively. The work function was calculated by the difference between the Fermi energy (E_F) of the system and the average electrostatic potential energy (V_∞) in the middle of the vacuum region: $\phi = V_\infty - E_F$. The calculations were done with a dipole correction in the z direction and the total local potential (vasp LOCPOT) contains only the electrostatic contributions (ionic and Hartree).

Results & Discussion

Construction and geometrical properties of the Cu(111)||Cu₂O(111) model

In preliminary calculations, we characterized the bulk properties of Cu-metal and Cu₂O-oxide as a first step to build the Cu(111)||Cu₂O(111) structure. The lattice parameters obtained by PBE,^{45,46} corrected by the semi empirical methods (DFT-D2 and DFT-D3) proposed by Grimme^{54,55} and non local functionals vdw-DF⁴⁸ are summarized in Table 1. We selected the optB86b functional optimized by Klimes et al,^{49,50} known for its ability to describe structural properties of solids.⁵⁶ We found that it allows a good compromise of the lattice parameters of bulk Cu-metal and Cu₂O-oxide with equilibrium lattice parameters of 3.599 (-0.30%) and 4.272 Å (+0.05%), respectively, which are in good agreement with experimental values of 3.61⁵⁷ and 4.27 Å.⁵⁸ The bulk was then cleaved to generate the surface structure.

The model used in the present calculations is derived from experimental data.^{1,11,17,59}

Table 1: Lattice parameter and lattice mismatch of copper and cuprite bulk structures calculated with PBE functional and different correction schemes of van der Waals forces.

	Cu metal		Cu ₂ O oxide		
	a (Å)	dev (%)	a (Å)	dev (%)	mismatch (%)
PBE	3.637	+0.74	4.311	+0.96	18.56
DFT-D2	3.573	-1.01	4.318	+1.12	20.84
DFT-D3	3.569	-1.11	4.264	-0.15	19.43
vdw-DF2	3.746	+3.78	4.421	+3.55	18.02
OptPBE-vdW	3.648	+1.06	4.327	+1.35	18.62
OptB88-vdW	3.628	+0.52	4.298	+0.66	18.45
OptB86b-vdW	3.599	-0.30	4.272	+0.05	18.70
Exp.	3.61 ⁵⁷		4.27 ⁵⁸		18.28

It has been shown that in the Cu(II) potential range, the Cu(111) metal substrate is fully covered by a well crystallized Cu₂O(111) oxide film in parallel epitaxy,^{1,5} which thickness is of 0.5 and 7 equivalent monolayers (ML) of Cu₂O(111) after growth at -0.25 and -0.2 V/SHE, respectively. Analysis of the observed structures showed a fit between oxide and substrate lattices over a coincidence length of 1.787 nm with a tilt angle of 5° assigned to epitaxial stress. This fit implies a contraction of 1% of the oxide lattice or an expansion of 1% of the substrate lattice with respect to the bulk values.

We thus built a supercell containing a (7×7) supercell of Cu(111) matching a (6×6) supercell of Cu₂O(111) stoichiometric oxide, and having the lateral dimensions of 1.781 nm in both x and y directions as calculated with optB86b functional. No tilt angle between the oxide layers and the metal was introduced. This constructed fit leads to the contraction of 1.7% of the oxide lattice relative to the bulk value, while the experimental value is 1%. It also leads to a higher mismatch (18.70 %) than the experimental one (18.28 %). We varied the oxide thickness by covering the Cu(111) metal by two to six stoichiometric Cu₂O(111) layers, corresponding to thicknesses ranging from 5.89 to 16.24 Å, as shown in Figure 1. The unrelaxed bare Cu₂O(111) surface shown in Figure 2 exhibits two distinct copper sites corresponding to coordinatively saturated (csa) and coordinatively unsaturated (cus) Cu atoms, labeled as Cu_{csa} and Cu_{cus}, respectively. It contains also two distinct oxygen sites corresponding to saturated and unsaturated oxygen atoms, labeled (O_{dn}) and (O_{up}),

respectively, where the subscripts indicate that they are located below (dn) and above (up) the surface Cu layer.

Interface description

In order to understand the interaction of Cu_2O with the Cu metal, we analyzed the interfacial cohesion energy as calculated by rigidly cleaving the relaxed interface structure to produce two free surfaces and not allowing these two free surfaces to relax (Eq.1). Figure 3 shows the variation of this interfacial cohesion energy with increasing thickness of the oxide.

The cohesion energy is positive in the range between 2.09 and 2.21 J/m², indicating the stable formation of the interface between the stoichiometric $\text{Cu}_2\text{O}(111)$ oxide and the $\text{Cu}(111)$ metal. The cohesion energy shows a slight decrease (about 5%) for a 3-fold increase of the oxide thickness (from 2 to 6 monolayers). The $\text{Cu}_2\text{O}(111)$ oxide binds to the $\text{Cu}(111)$ substrate surface through the bonding of the unsaturated oxygen atoms to the copper metal atoms. The oxygen atoms move laterally and are located on top, bridge and hollow sites on $\text{Cu}(111)$ metal surface as illustrated in Figure 4. This result contrasts with that of Soon et al,²⁸ who found that the bridge site is energetically less favorable as compared to the fcc-hollow site for O adsorbed on $\text{Cu}(111)$. The Cu-O distances at the interface between copper metal and oxygen of the oxide is between 1.97 and 2.08 Å on the top site, in the range between 2.06 and 2.40 Å on the bridge site and between 2.17 and 2.35 Å on the hollow site.

Surface description

It is known that the $\text{Cu}_2\text{O}(111)$ surface reconstructs after cleavage of the bulk structure.^{18,20,60,61} There are three symmetry equivalent directions along which Cu_{cus} ions may relax, with slightly different relaxation energies.⁶⁰ For $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$, we found the same tendency, the reconstructed $\text{Cu}_2\text{O}(111)$ surface being more stable by about 4 meV/Å² than the high symmetry unreconstructed $\text{Cu}_2\text{O}(111)$ surface. The high symmetry around the

unsaturated copper atoms is broken and the Cu_{cus} atoms relax laterally toward an adjacent saturated Cu_{csa} atom, as shown in Figure 1f for non supported $\text{Cu}_2\text{O}(111)$ model. However, for $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$ model the Cu_{cus} ions relax toward Cu_{csa} ions without any preferential direction, except for the 6-layer thick oxide.

Table 2: Comparison of distances and bond lengths ($\text{\AA}$) at the oxide surface before and after relaxation, for non supported $\text{Cu}_2\text{O}(111)$ and supported $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$ with oxide thickness ranging from 2 to 6 monolayers (ML). Distances and bond lengths are illustrated in Figure 2. $\text{Cu}_{cus}-\text{Cu}_{csa}^1$ and $\text{Cu}_{cus}-\text{Cu}_{csa}^2$ correspond to the contraction and elongation $\text{Cu}_{cus}-\text{Cu}_{csa}$ distances

Systems	$\text{Cu}_2\text{O}(111)^{urlx}$	$\text{Cu}_2\text{O}(111)^{rlx}$	$\text{Cu}(111) \text{Cu}_2\text{O}(111)^{urlx}$	$\text{Cu}(111) \text{Cu}_2\text{O}(111)^{rlx}$
$\text{O}_{dn}-\text{Cu}_{csa}$	1.85	1.89	1.82	1.87 ± 0.01
$\text{O}_{up}-\text{Cu}_{CSA}$	1.85	1.85	1.82	1.82 ± 0.01
$\text{Cu}_{cus}-\text{Cu}_{csa}^1$	3.02	2.45	2.97	2.36-2.45
$\text{Cu}_{cus}-\text{Cu}_{csa}^2$	3.02	3.59	2.97	3.59-4.20

Table 2 shows the O-Cu and $\text{Cu}_{csa}-\text{Cu}_{cus}$ distances (Figure 2) measured at the $\text{Cu}_2\text{O}(111)$ surface before and after relaxation for the non supported oxide and supported oxide. On the unrelaxed clean surface without lateral compression ($\text{Cu}_2\text{O}(111)^{urlx}$), the $\text{O}_{up}-\text{Cu}_{csa}$ and $\text{O}_{dn}-\text{Cu}_{csa}$ distances are 1.85 $\text{\AA}$ and the $\text{Cu}_{csa}-\text{Cu}_{cus}$ distance is 3.02 $\text{\AA}$, while they are shorter by 0.03 and 0.05 $\text{\AA}$ respectively, with lateral compression ($\text{Cu}(111)||\text{Cu}_2\text{O}(111)^{urlx}$). For the supported oxide after relaxation and independently of the oxide thickness, the $\text{O}_{dn}-\text{Cu}_{csa}$ distance is longer (1.87 ± 0.01 $\text{\AA}$) and the $\text{O}_{up}-\text{Cu}_{csa}$ distance is shorter (1.82 ± 0.01) compared to the ideal oxide surface ($\text{Cu}_2\text{O}(111)^{urlx}$). These results are in line with that of Soon et al.,²⁸ who reported a compression by 2.1% of O-Cu distance compared to that in the ideal oxide surface structure, due to the strong lateral constraint imposed to the supported oxide by using a supercell of 4×4 . Because the high-symmetry of Cu_{cus} is broken after relaxation, the $\text{Cu}_{csa}-\text{Cu}_{cus}$ distance is significantly changed. As mentioned previously, the Cu_{cus} atoms move toward the Cu_{csa} sites, without preferential direction, because it has six Cu_{csa} neighboring sites, which leads to the elongation of some $\text{Cu}_{csa}-\text{Cu}_{cus}$ distances and contraction of others. According to the relaxation direction of the Cu_{cus} atoms and the oxide thicknesses, the shorter distance ranges between 2.36 and 2.45 $\text{\AA}$, and longer distance ranges

between 3.59 and 4.20 Å.

The relaxation of the surface was also attested by the surface interlayer distance variation, shown in Figure 5 and calculated by the following equation:

$$\Delta d = \frac{d_s - d_{bulk}}{d_{bulk}} \times 100 \quad (8)$$

where d_s is the distance between the surface and the subsurface layers and d_{bulk} is the equivalent distance in the Cu₂O bulk oxide.

It is interesting to notice that the direction of relaxation is opposite for the supported and non supported Cu₂O oxides. For the Cu₂O(111)||Cu(111), the surface interlayer relaxation is inward, i.e. the distance between the two topmost layer decreases compared to that in the bulk (2.47 Å). In contrast, the surface interlayer relaxation is outward in the non supported Cu₂O(111) oxide. The interlayer distance converges toward the bulk value and reaches -0.42% and +3.67% for the supported Cu₂O(111)||Cu(111) and non supported Cu₂O(111) oxides, respectively, with the 6 monolayer model.

These results show an opposite relaxation deviation of the interlayer distance induced by the underlying copper metal, and a slight effect of the constraint imposed to the oxide on the distance between the Cu_{cus} and Cu_{csa} atoms.

Electrons distribution

We used Bader charge analysis to identify the electrons distribution in the metal-oxide system and the results are compared to experimental and theoretical literature data. The results are presented in Table 3. In the oxide, the results show that the electrons distribution is independent of the oxide thickness. We found the presence of oxidized copper atoms and oxygen anions in the inner layers (i.e. bulk) of the oxide, on the surface and at the interface. We also found the expected metallic character of the metal support. In the bulk oxide, the

copper cations have a Bader charge in the range between +0.5 and +0.6 electron, while oxygen anions exhibit typical charge of about -1 electron. The Bader charge analysis of the electrons distribution in the oxide is in good agreement with other theoretical charge distributions^{62–64} and also in line with the results of a high-energy synchrotron experimental investigation.⁶⁵ The surface and the interface of the oxide contain saturated (Cu_{csa}) and unsaturated (Cu_{cus}) copper cations. The Cu_{csa} cations exhibit a charge like in Cu cations in the bulk oxide, whereas the Cu_{cus} exhibit a lower charge in the range between +0.30 and +0.37 electron on the surface and of +0.19 and +0.20 electron at the interface with the metal. In the metal, Bader charge analyses shows the absence of charge (Cu^{+0}) in the bulk ($\Delta Q < \pm 0.03$ electron) and two types of copper atoms at the interface. The copper atoms bear charges varying from +0.10 to +0.20 electrons when involved in the interaction with oxygen atoms of the oxide, whereas the other copper atoms remain of metallic character ($\Delta Q < \pm 0.03$ electrons). This evidences a local electron transfer for the copper atoms involved in the interaction with oxygen atoms at the metal-oxide interface. The low charge transfer observed agrees with the more covalent than ionic nature of Cu_2O .⁶⁶ The covalent character of Cu_2O might explain the strong cohesion energy calculated, as it has been proposed that increasing the oxide covalency increases the metal/oxide interface strength.⁶⁷

Table 3: Bader charge analysis of the electrons distribution (electron) on the $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$ model with oxide thickness ranging from 2 to 6 monolayers.

	This work	Ref. ^{62–64}	Ref. ⁶⁵
Cu-metal			
Cu-inner	$< \pm 0.03$		
Cu-metal/inter ¹			
Cu-metal/inter ²	+0.10 to +0.20		
Cu-oxide			
Cu-inner	+0.50 to +0.60	+0.53	+0.57 to +0.84
Cu_{csa} /surf			
Cu_{csa} /inter			
Cu_{cus} /surf	+0.30 to +0.37		
Cu_{cus} /inter	+0.19 to +0.20		
O	-1.03 to -0.99	-1.07 to -1.05	-1.68 to -1.14

Work function change and electrons transfer

Table 4: Work function (ϕ in eV) for the Cu(111) and Cu₂O(111) surface and work function change with respect to the metal work function ($\Delta\phi$ in eV) and electrons transfer (ΔQ in e/Å²) as function of the oxide thickness for the Cu₂O(111)||Cu(111) model.

	Cu(111)	Cu ₂ O(111)	Cu(111) Cu ₂ O(111) Oxide thickness (ML)				
			2	3	4	5	6
ϕ	5.09	5.03					
$\Delta\phi$			-0.07	+0.04	+0.02	-0.08	-0.03
ΔQ					0.007		

Table 4 shows the work function (ϕ) of the Cu(111) and Cu₂O(111) surfaces and the work function change ($\Delta\phi$) and electrons transfer (ΔQ) as a function of the oxide thickness for the Cu₂O(111)||Cu(111) model. The formation of the Cu₂O(111) stoichiometric oxide on the Cu(111) metal induces no significant change on the metal work function, which can be explained by the low charge transfer calculated after interaction and by the close work functions of the metal and the oxide. The work function change is related to the electrons transfer and, indeed, the Bader charge analysis reveals electrons transfer from the metal to the oxide of only 0.007 e/Å². We calculated work functions of the Cu metal and the Cu₂O oxide of 5.09 and 5.03 eV, respectively. These results contrast with those obtained for structures of oxygen adsorbed on the Cu surface, for which a work function change of 1.17 eV at 0.25 ML O coverage was calculated.²⁸

Reactivity toward water molecules and OH groups

In order to model the experimental conditions of the copper surface in contact with an aqueous solution, we investigated the molecular and dissociative adsorption of water molecules and compared our results with literature data of water adsorbed on non supported Cu₂O(111) oxide. We also hydroxylated the surface with OH groups placed on Cu_{cus}. Two oxide thicknesses were considered, corresponding to 2 and 4 stoichiometric Cu₂O(111) layers.

The results are presented in Figures 6 to 9. Figures 6 and 7 show the snapshots of

the starting and the most stable optimized configurations of molecular and dissociative adsorption of water molecules at low and high coverage, respectively. Figures 8 and 9 show snapshots of OH adsorption at low and high coverage, respectively. Table 5 summarizes the adsorption energies of molecular water and OH at low and high coverage compared to the literature data. More details on the water-surface and OH-surface binding for two oxide thicknesses (2 and 4 stoichiometric Cu_2O layers) are given by the charge density difference analysis ($\Delta\rho(r)$) calculated by Eq.5 and plotted in Figure 10, with isosurface of $\pm 0.0004 \text{ e}/\text{\AA}^3$.

Table 5: Adsorption energies (eV/mol) of water molecule and radical OH° at low and full coverage as calculated with Eq.2 and Eq.3, respectively. Values in brackets correspond to the adsorption energy normalized per unit area (J/m^2), calculated with Eq.4.

Oxide thickness $\text{Cu}_2\text{O}(111)$ monolayers	coverage (mol/nm ²)	H_2O adsorption energy (eV/mol)	OH° adsorption energy (eV/mol)
2	0.37	-1.26 (-0.07)	-3.74 (-0.22) / -4.70 (-0.27)
2	3.27	-1.10 (-0.57)	-3.71 (-1.95)
4	3.27	-1.09 (-0.57)	-3.57 (-1.87)
non supported oxide	$\frac{1}{4} \text{ ML}^{20}$	-1.70	
	1 ML^{20}	-1.01	
	1 ML^{68}	-1.03	

We found that independently of the oxide thickness, the water molecular adsorption (as shown in Figures 6 and 7) is favored over dissociative adsorption. The adsorption energy of the water molecule on $\text{Cu}(111)$ covered by two $\text{Cu}_2\text{O}(111)$ layers is -1.26 and -1.10 eV/molecule at low and full coverage, respectively. On $\text{Cu}(111)$ covered by four $\text{Cu}_2\text{O}(111)$ layers, the value is -1.09 eV/molecule at full coverage. The water molecules prefer to bind on top of unsaturated copper sites via the oxygen atom, with a bond length $\text{Cu}\dots\text{O}$ of $1.96\pm 0.01 \text{ \AA}$. The $\text{Cu}\dots\text{O}$ bond is confirmed by the charge density difference analysis in Figure 10, that shows the accumulation of electron charge (blue color) between the oxygen atom of the water molecules and the unsaturated copper atoms of the oxide surface. We also observed the formation of a $\text{H}-\text{O}-\text{H}\dots\text{O}$ hydrogen bond with an adjacent unsaturated oxygen with a $\text{H}\dots\text{O}$ distance of $1.69\pm 0.01 \text{ \AA}$ and $1.74\pm 0.04 \text{ \AA}$, on the two and four Cu_2O layer thick

models, respectively. The orientation of the hydrogen atom of the water molecule toward the unsaturated oxygen atom of the oxide surface and also the deficit and accumulation of electrons charge on the hydrogen (positive charge) and the unsaturated oxygen (negative charge) atoms (Figure 10), respectively, are typical features of H-bonding. Note that even when starting the calculations in the dissociative adsorption mode (Figure 7), we observed the reformation of intact water molecules at the end of the optimization process, which confirms preferential molecular adsorption of water on Cu(111)||Cu₂O(111) surface. The water molecules were again adsorbed on unsaturated copper sites with the formation of H-bond. However at full coverage, one water molecules remains in the dissociative adsorption mode, with the OH group adsorbed atop on unsaturated copper and the H atom bounded to an unsaturated oxygen atom (Figure 7). This configuration allows us to estimate the dissociative energy of water molecule on the substrate surface. We calculated the value of 0.17 eV.

It is now interesting to compare our results of H₂O adsorption on the supported Cu(111)||Cu₂O(111) oxide with literature data of H₂O adsorption on non supported Cu₂O(111) oxide. Our results of favored molecular over dissociative adsorption are in agreement with literature data on the non supported oxide surface, showing that the oxide acid-base reactivity does not depend on the oxide layer thickness neither on the presence of the underlying Cu metal. The adsorption at high coverage is favored over that at low coverage, the gain in the adsorption is $\varepsilon_{norm} = 0.50 \text{ J/m}^2$ (Table 5). The adsorption energy is also in accordance with previous theoretical results.^{20,68} Independently of coverage, the water molecule prefers molecular adsorption like observed on Cu₂O(111) surfaces built with periodic^{20,68,69} or cluster¹⁹ models and also on Cu₂O(111) surface with Cu-vacancy.⁶⁸ In the latter case, the water molecule binds via H-bonding to oxygen in the sub layer, in the Cu-vacancy and with the oxygen atom of the molecule is tilted toward Cu_{csa} site. However the dissociative adsorption mode of H₂O molecule can be preferential if the Cu₂O(111) surface contains O-vacancies^{20,69} and also on the polar surfaces like the Cu-terminated, Cu-rich and O-rich Cu₂O(111) surfaces.⁶⁴

We also analyzed the adsorption of OH groups particularly present in alkaline solutions.

Figures 8 and 9 show the results obtained at low and high coverage, respectively. The interaction mechanism of the OH groups with the surface is different from that of the water molecules. It does not show the formation of H-bonding and can involve both saturated and unsaturated copper surface atoms.

At low coverage, two optimized configurations were analyzed, due to their difference in the interaction mechanism. The first configuration has an adsorption energy of -3.74 eV, and corresponds to the adsorption of OH on top of an unsaturated copper atom with a bond length Cu...OH of 1.78 Å and without the formation of H-bonding between the OH group and the unsaturated oxygen surface atoms. The adsorption of OH in this configuration does not affect the structural environment of the neighboring atoms as compared to the bare Cu₂O(111) surface.

The second configuration presents an adsorption energy of -4.69 eV and is more stable by -0.95 eV. The OH group binds in a bridge mode with bond lengths Cu_{cus}...O of 1.88 Å and Cu_{csa}...O of 1.89 Å. There is no H-bonding like in the first described configuration but there is a change in the structural environment of the neighboring surface atoms: i) broken bonding of an adjacent saturated copper with an unsaturated oxygen with a Cu_{csa}-O_{up} bond length increase from 1.83 Å to 2.97 Å, the Cu_{csa} atom relaxes to bind to the OH group with a bond length of 1.89 Å; ii) the neighbor Cu_{cus} atom becomes a Cu_{csa} atom, it moves to bind with an unsaturated oxygen (Cu-O distance changes from 2.9 to 1.88 Å) that loses a bond with a saturated copper atom.

At high coverage, all unsaturated copper atoms of the Cu₂O surface are bounded to OH groups. After relaxation, we observed two types of OH bonding. $\frac{2}{9}$ of OH groups in the supercell are μ_1 -OH groups, i.e. with OH adsorbed on top of unsaturated copper atoms, with bond length of 1.78 Å. This adsorption mode corresponds to that found at low coverage for the less stable configuration. $\frac{7}{9}$ of the OH groups in the supercell are μ_2 -OH groups, i.e. with each OH bonded in bridge mode to two copper atoms. The Cu...O bond lengths are 1.84 Å and 2.12 Å with unsaturated and adjacent saturated copper atoms, respectively. Both types

of OH bonds show bond-making without bond-breaking. The reason is that all unsaturated copper atoms become saturated after bonding with OH groups. More details about the Cu...O bond formation are given by $\Delta\rho(r)$ analysis in Figure 10 that shows electrons charge accumulation on the oxygen of the OH groups and local redistribution of electrons charge on copper surface atoms. We calculate a low deficit of the electrons charge on the unsaturated copper and higher deficit of the electrons charge on the saturated copper atoms particularly for those bonded to the μ_2 -OH groups.

The adsorption energy is -3.72 eV/molecule. The adsorption energy per OH at full coverage is lower than at low coverage, however, when the adsorption energy is normalized to a unit area (Table 5), the full coverage is more favorable, because more OH groups are adsorbed per unit area. The results also show that the adsorption of OH groups is more stable than the intact water molecule (energy difference of 2.62 eV). The energetic trend suggests that surface saturation by OH groups of the Cu(111)||Cu₂O(111) supported oxide is, in principal, favored in conditions where OH group adsorption can compete with water molecular adsorption, but that it would not likely happen by direct dissociation of water molecules.

Conclusions

In this paper, we presented a DFT-based construction and optimization of Cu₂O(111) oxide supported in parallel epitaxy on the Cu(111) as model for metallic copper covered by an ultrathin Cu(II) oxide. Hydration and hydroxylation of the topmost surface of the supported Cu(111)||Cu₂O(111) model was discussed. We provided results for structural, energetic and electronic properties of dry, hydrated and hydroxylated systems. The results were compared to equivalent data on non supported Cu₂O(111) oxide.

We found the stable formation of stoichiometric Cu₂O(111) oxide in parallel epitaxy on the Cu(111) metal. The interfacial cohesion energy decreases slightly with increasing oxide

thickness. We showed that the surface relaxation is independent of the oxide thickness, and similar to that of the non supported $\text{Cu}_2\text{O}(111)$ oxide with slight effect on Cu_{cus} - Cu_{csa} distance imposed by the lateral constraint in the supported oxide. The underlying copper metal was found to modify the relaxation changes in the deviation of the surface interlayer distance as compared to the non supported oxide, and converges to that of bulk oxide with increasing the $\text{Cu}_2\text{O}(111)$ thickness.

Bader charge analyses revealed the metallic and oxide character of the copper metal atoms at the metal and oxide planes forming the interface. The close values of the work function of the metal and the oxide combined to the weak electron exchange at the interface causes non significant variation of the metal work function, whatever the thickness of the supported oxide.

Independently of the oxide thickness, water molecules prefer molecular adsorption rather than dissociative adsorption. The adsorption at high coverage is favored over that at low coverage. The electronic analysis confirms that the water molecules bind covalently via O to Cu_{cus} atoms and form also H-bonds with O_{up} surface atoms.

The hydroxylation of the surface shows two types of bonding for the adsorbed OH groups; OH- μ_1 and OH- μ_2 , with predominance of OH- μ_2 mode. In OH- μ_1 mode, the OH group is chemisorbed via the O atom on top of a Cu_{cus} atom, whereas in the OH- μ_2 mode, the OH is chemisorbed via the O atom bridging the Cu_{cus} and Cu_{csa} atoms. The energetic trend suggests that the complete surface hydroxylation of the $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$ supported oxide is favored in conditions where OH group adsorption can compete with water molecular adsorption.

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Graphical TOC Entry

Figure 1: Snapshots (top and side views) of Cu(111) covered by stoichiometric $\text{Cu}_2\text{O}(111)$ in parallel epitaxy with thickness from two (a) to six (e) layers. (f) is the non supported 5-layer thick $\text{Cu}_2\text{O}(111)$ oxide.

Figure 2: Surface sites, bond lengths and distances of Cu₂O(111). Cu_{cus} and Cu_{csa} correspond to unsaturated and saturated copper surface sites, respectively. O_{up} and O_{dn} correspond to unsaturated and saturated oxygen surface sites, respectively. $d(O_{dn} \dots Cu_{csa})$ and $d(O_{up} \dots Cu_{csa})$ are the bond length of O_{dn} and O_{up} to Cu_{csa} atoms, respectively. $d(Cu_{cus} \dots Cu_{csa})$ is the distance between Cu_{cus} and Cu_{csa} atoms.

Figure 3: Cohesion energy of Cu(111)||Cu₂O(111) interface as calculated with Eq. 1 as a function of the oxide thickness.

Figure 4: Details of the O to metallic Cu bonding at the oxide-metal interface in Cu(111)||Cu₂O(111) model. For visualization we kept only the last metallic layer of copper metal and first oxygen layer of the oxide at the interface.

Figure 5: Deviation of the calculated surface interlayer distance with respect to bulk for the supported Cu(111)||Cu₂O(111) and non supported Cu₂O(111) oxides.

Figure 6: Top view of water molecular adsorption on Cu(111)||Cu₂O(111) at low coverage (0.37 mol/nm²).

Figure 7: Starting and optimized configurations of molecular and dissociative adsorption of water on $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$ at high coverage (3.27 mol/nm^2).

Figure 8: Top view of OH° group adsorbed on $\text{Cu}(111)||\text{Cu}_2\text{O}(111)$ at low coverage (0.37 mol/nm^2). Top row corresponds to OH° adsorbed on a top Cu site. Bottom row corresponds to OH° adsorbed on a bridge Cu site. Circles in zoom area correspond to the Cu position before adsorption.

Figure 9: Adsorption of OH° group on Cu(111)||Cu₂O(111) at high coverage (3.27 mol/nm²). Mixed adsorption mode on a top and bridge sites.

Figure 10: Charge density difference analysis for H₂O and OH group adsorbed on Cu(111)||Cu₂O(111) at high coverage (3.27 mol/nm²). Blue and green color correspond to accumulation and deficit of charge density, respectively